

<b>Notice of References Cited</b>	Application/Control No. <b>10/453,346</b>	Applicant(s)/Patent Under Reexam <b>Prathima Agrawal et al.</b>	
	Examiner <b>Naghmeh Mehrpour</b>	Art Unit <b>2685</b>	Page 1 of 1

**U.S. PATENT DOCUMENTS**

	Document Number <small>Country Code-Number-Kind Code</small>	Date <small>MM-YYYY<sup>1</sup></small>	Name	Classification <sup>2</sup>	
A	6,208,864 B1	3/2001	Agrawal et al.	455	445
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